

September 2007

FDC637BNZ

N-Channel 2.5V Specified PowerTrench® MOSFET

20V, **6.2A**, **24m** Ω

Features

- Max $r_{DS(on)} = 24m\Omega$ at $V_{GS} = 4.5V$, $I_D = 6.2A$
- Max $r_{DS(on)}$ = 32m Ω at V_{GS} = 2.5V, I_D = 5.2A
- Fast switching speed
- Low gate charge (8nC typical)
- High performance trench technology for extremely low r_{DS(on)}
- SuperSOT™-6 package: small footprint (72% smaller than standard SO-8; low profile (1mm thick)
- HBM ESD protection level > 2kV typical (Note 3)
- Manufactured using green packaging material
- Halide-Free
- RoHS Compliant

General Description

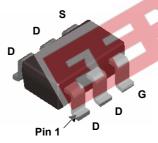
This N-Channel 2.5V specified MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

These devices have been designed to offer exceptional power dissipation in a very small footprint compared with bigger SO-8 and TSSOP-8 packages.

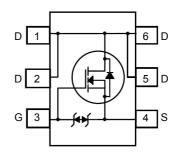
Applications

- DC DC Conversion
- Load switch
- Battery Protection





SuperSOTTM -6



MOSFET Maximum Ratings TA= 25°C unless otherwise noted

Symbol	Pa		Ratings	Units	
V _{DS}	Drain to Source Voltage			20	V
V _{GS}	Gate to Source Voltage			±12	V
1	Drain Current -Continuous	T _A = 25°C	(Note 1a)	6.2	۸
ID.	-Pulsed			20	Α
D	Power Dissipation	T _A = 25°C	(Note 1a)	1.6	w
P_{D}	Power Dissipation	T _A = 25°C	(Note 1b)	0.8	VV
T _J , T _{STG}	Operating and Storage Junction Terr	perature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	78	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	156	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
.637Z	FDC637BNZ	SSOT6	7"	8mm	3000 units

Electrical Characteristics T_J = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	20			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C		10		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 16V, V _{GS} = 0V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 12V, V_{DS} = 0V$			±10	μΑ

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	0.6	0.8	1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C		-3		mV/°C
		V _{GS} = 4.5V, I _D = 6.2A		21	24	
r _{DS(on)}	Static Drain to Source On Resistance	V_{GS} = 2.5V, I_{D} = 5.2A		26	32	mΩ
		V_{GS} = 4.5V, I_{D} = 6.2A, T_{J} = 125°C		30	41	1
g _{FS}	Forward Transconductance	V _{DD} = 5V, I _D = 6.2A		27		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V = 40V V = 0V	670	895	pF
Coss	Output Capacitance	V _{DS} = 10V, V _{GS} = 0V, f = 1MHz	160	215	pF
C _{rss}	Reverse Transfer Capacitance	1 - 11/11/2	115	175	pF
R_q	Gate Resistance	f = 1MHz	2.1		Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time	100	8	16	ns
t _r	Rise Time	$V_{DD} = 10V, I_D = 6.2A$	6	12	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 4.5 \text{V}, R_{GEN} = 6\Omega$	22	36	ns
t _f	Fall Time		6	12	ns
Q_{g}	Total Gate Charge	V 4.5V.V 40V	8	12	nC
Q_{gs}	Gate to Source Gate Charge	──V _{GS} = 4.5V, V _{DD} = 10V, ──I _D = 6.2A	1.3		nC
Q_{gd}	Gate to Drain "Miller" Charge	1D - 0.2A	2.2		nC

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain-Source Diode Forward Current				1.3	Α
V_{SD}	Source to Drain Diode Forward Voltage $V_{GS} = 0V$, $I_S = 1.3A$ (Note 2)			0.7	1.2	V
t _{rr}	Reverse Recovery Time	I _E = 6.2A, di/dt = 100A/μs		15	27	ns
Q _{rr}	Reverse Recovery Charge	11 _F = 0.2A, αι/αι = 100A/μS		5	10	nC

Notes:

Notes:

1. R_{0,JA} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,JC} is guaranteed by design while R_{0,JA} is determined by the user's board design.



a. 78°C/W when mounted on a 1 in² pad of 2 oz copper.



4.

b. 156°C/W when mounted on a minimum pad of 2 oz copper.

^{2.} Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.

^{3.} The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics T_J = 25°C unless otherwise noted

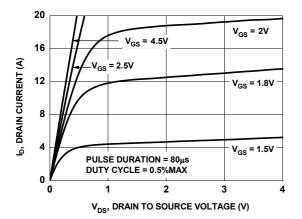


Figure 1. On-Region Characteristics

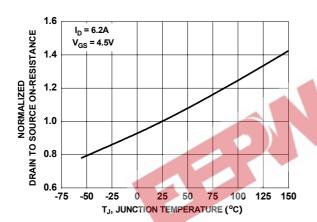


Figure 3. Normalized On-Resistance vs Junction Temperature

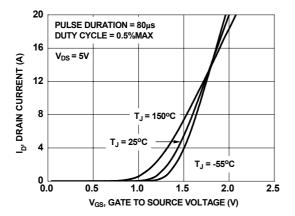


Figure 5. Transfer Characteristics

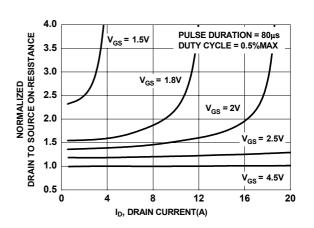


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

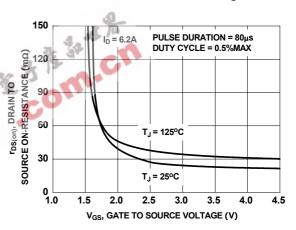


Figure 4. On-Resistance vs Gate to Source Voltage

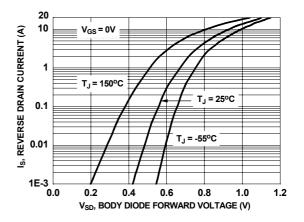


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25°C unless otherwise noted

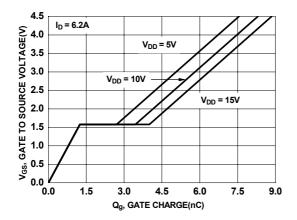


Figure 7. Gate Charge Characteristics

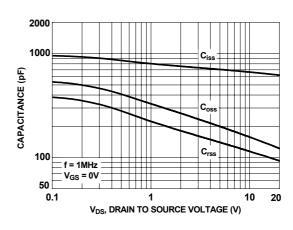


Figure 8. Capacitance vs Drain to Source Voltage

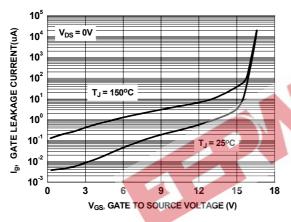


Figure 9. Gate Leakage Current vs Gate to Source Voltage

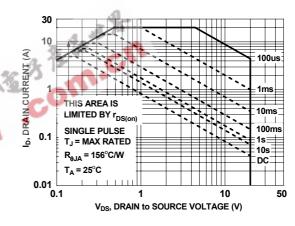


Figure 10. Forward Bias Safe Operating Area

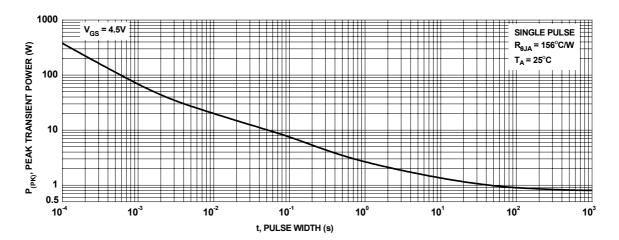
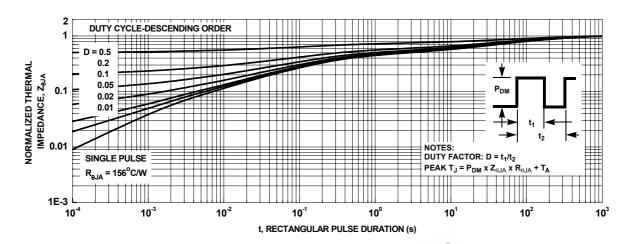


Figure 11. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25°C unless otherwise noted







TRADEMARKS

The following are registered and unregistered trademarks and service marks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

 $\mathsf{ACEx}^{\mathbb{R}}$ Power247® Green FPS™ SuperSOT™-8 POWEREDGE® SyncFET™ Build it Now™ Green FPS™ e-Series™ CorePLUS™ GTO™ Power-SPM™ The Power Franchise® CROSSVOLT™ i-Lo™ PowerTrench® p wer CTL™ IntelliMAX™ Programmable Active Droop™ QFET® Current Transfer Logic™ ISOPLANAR™ TinyBoost™ QS™ EcoSPARK® MegaBuck™ TinyBuck™ $\mathsf{TinyLogic}^{\circledR}$ Fairchild® MICROCOUPLER™ QT Optoelectronics™ MicroFET™ Quiet Series™ **TINYOPTO™** Fairchild Semiconductor® MicroPak™ RapidConfigure[™] TinyPower™ TinyPWM™ MillerDrive™ FACT Quiet Series™ SMART START™ FACT[®] Motion-SPM™ SPM[®] TinyWire™ $\mathsf{FAST}^{\mathbb{R}}$ OPTOLOGIC® STEALTH™ µSerDes™ FastvCore™ OPTOPLANAR® SuperFET™ UHC® SuperSOT™-3 FPS™ UniFET™ FRFET® SuperSOT™-6 PDP-SPM™ VCX™ Global Power ResourceSM Power220®

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information Formative or In Design		This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary First Production		This datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
		This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
Obsolete Not In Production		This datasheet contains specifications on a product that has been discontinued by Fairchild Semiconductor. The datasheet is printed for reference information only.

Rev. I31